

Search Notes

Application/Control No.

10/705,863

Examiner

Duc M. Nguyen

Applicant(s)/Patent under
Reexamination

HIBINO ET AL.

Art Unit

2685

SEARCHED

Class	Subclass	Date	Examiner
455	193.1		
	193.2		
	193.3		
	199.1		
	179.1		
	180.2		
	188.1		
	188.2		
	191.2		
	191.3		
	269		
	275		
	285->291		
	339		
	340		
333	124		
	129		
	132		
	32		
	172		
	174		
	227		
	231	3/6/06	DN

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST	2/21/2006	DN
EAST	3/6/2006	DN